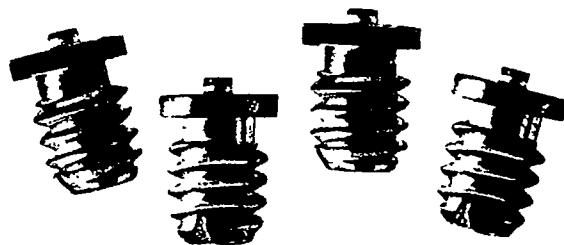


**GALLIUM ARSENIDE
PULSED IMPATT DIODES**
9251 Series 5-21 GHz

- High Peak Output Power
- High Efficiency—Typically 18–20%
- Burnout Resistant to Circuit Mismatches
- High Reliability—Greater than 10^6 hrs MTTF
- Pulse Widths from 0.25 to 30 μ sec
- Duty Cycles from 0.5% to 35%

DESCRIPTION

Litton 9251 diodes are hi-low, gallium arsenide IMPATT diodes. They are especially ideal for use in injection-locked oscillators and amplifier stages in missile seekers and radar transmitters. Rugged, reliable diode construction is assured by using a grown P+ hi-low doping profile with a high-temperature metallization process on P+N+N-N+ GaAs. These diodes can be readily combined in multiple diode oscillators.

**ABSOLUTE MAXIMUM RATINGS**

Junction Operating Temperature 225°C
 Storage Temperature 225°C
 Soldering Temperature, 5 sec. maximum 230°C

GENERAL CHARACTERISTICS

Frequency Range (GHz)	Minimum RF Power (W)	Minimum Efficiency (%)	Typical Operating Voltage (V)	Typical Operating Current (A)	Typical Breakdown Voltage (V)	Typical Device Capacitance (pF)	Typical Thermal Resistivity ($^{\circ}$ C/W)	Part Number (Package)
5-7	16	16	85	1.2	70	3.5	7.0	VSC 9251 S1 (N23)
	19	18	86	1.2	72	3.5	7.0	VSC 9251 S2 (N23)
8-10	17	19	60	1.5	45	3.0	7.5	VSX 9251 S1 (N57)
	20	21	64	1.5	47	3.0	7.5	VSX 9251 S2 (N57)
14-16	10	18	35	1.6	28	2.9	8.5	VSU 9251 S1 (N58)
	12	20	38	1.6	29	2.9	8.5	VSU 9251 S2 (N58)
19-21	8	18	32	1.4	20	1.9	14.0	VSK 9251 S1 (N113)
	10	20	35	1.4	22	1.9	14.0	VSK 9251 S2 (N113)

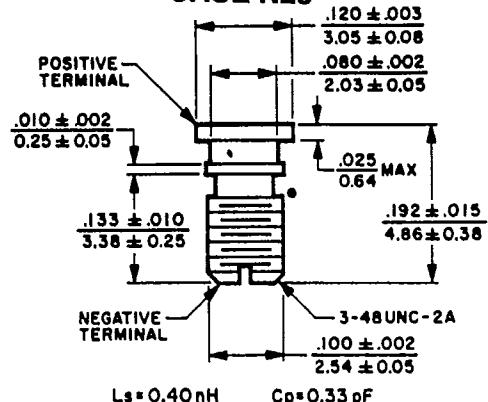
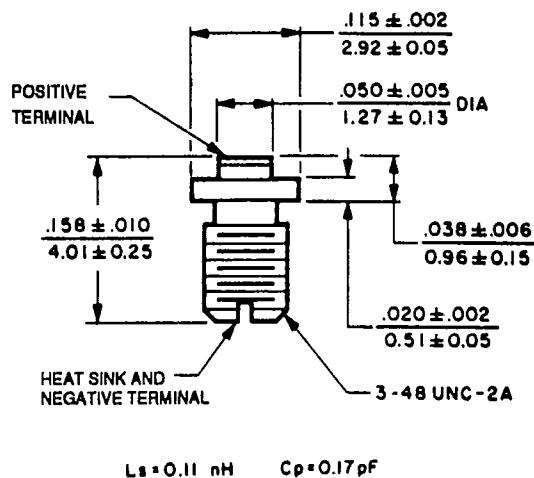
NOTES:

1. RF performance is measured at an ambient of 25°C in a hi-Q coaxial or waveguide test cavity. Cavity design information is available upon request. Data shown is for pulse lengths of 10 μ sec, 1% duty cycle. High duty cycle operation requires a custom-designed part for reliable operation. Special considerations are required for use of other media (microstrip, suspended-substrate); information available upon request.
2. Reverse Breakdown Voltage (BV), measured with a reverse current of 1 mA.
3. Device capacitance measured under a reverse bias voltage of 80% of BV.
4. S-Parameter data for design of matching circuits is available upon request.

Littton**Solid State**

3251 Olcott Street / Santa Clara, CA 95054 / 408-988-1331 or 408-988-1845

OUTLINE DRAWINGS

CASE N23**CASE N57/N58**

DIMENSIONS: $\frac{\text{inch}}{\text{mm}}$

CASE N113